

REVISIONS

LTR	DESCRIPTION	DATE (YR-MO-DA)	APPROVED
C	Convert to military drawing format. Add case outline 2 (square chip carrier package) for vendor CAGE (27014). Remove vendor from case A and add to case D. Devices 01CX and 012X inactive for new design use M38510/65204BCX and M38510/65204B2X. Change	88 MAR 24	<i>M. A. [Signature]</i>

CURRENT CAGE CODE 67268

[illegible]

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5962-E398-6

DISTRIBUTION STATEMENT A. Approved for public release; distribution is unlimited.

1. SCOPE

1.1 Scope. This drawing describes device requirements for class B microcircuits in accordance with 1.2.1 of MIL-STD-883, "Provisions for the use of MIL-STD-883 in conjunction with compliant non-JAN devices".

1.2 Part number. The complete part number shall be as shown in the following example:

84048	01	A	X
-----	-----	-----	-----
Drawing number	Device type (1.2.1)	Case outline (1.2.2)	Lead finish per MIL-M-38510

1.2.1 Device type. The device type shall identify the circuit function as follows:

Device type	Generic number	Circuit
01	54HC11	Triple three-input AND gate

1.2.2 Case outlines. The case outlines shall be as designated in appendix C of MIL-M-38510, and as follows:

Outline letter	Case outline
A	F-1 (14-lead, .280" x .260" x .085") flat package
B	F-3 (14-lead, .280" x .200" x .070") flat package
C	D-1 (14-lead, .785" x .310" x .200") dual-in-line package
D	F-2 (14-lead, .390" x .260" x .085") flat package
2	C-2 (20-terminal, .358" x .358" x .100") square chip carrier package

1.3 Absolute maximum ratings.

Supply voltage range 1/	- - - - -	-0.5 V dc to +7.0 V dc
DC input voltage-	- - - - -	-0.5 V dc to V_{CC} +0.5 V dc
DC output voltage	- - - - -	-0.5 V dc to V_{CC} +0.5 V dc
Clamp diode current	- - - - -	±20 mA
DC output current (per pin)	- - - - -	±25 mA
DC V_{CC} or GND current (per pin)	- - - - -	±50 mA
Storage temperature range	- - - - -	-65°C to +150°C
Maximum power dissipation (P_D)	- - - - -	500 mW 2/
Lead temperature (soldering, 10 seconds)	- - - - -	+260°C
Thermal resistance, junction-to-case (θ_{JC})	- - - - -	
Cases A, B, C, D, and 2	- - - - -	See MIL-M-38510, appendix C
Junction temperature (T_J)	- - - - -	+175°C

1/ Unless otherwise specified all voltages are referenced to ground.

2/ For $T_C = +100^\circ\text{C}$ to $+125^\circ\text{C}$, derate linearly at 12 mW/°C.

STANDARDIZED MILITARY DRAWING DEFENSE ELECTRONICS SUPPLY CENTER DAYTON, OHIO 45444	SIZE A	84048
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1.4 Recommended operating conditions.

Supply voltage range- - - - -	+2.0 V dc to +6.0 V dc
Case operating temperature range (T_C) - - - - -	-55°C to +125°C
Input rise or fall time:	
$V_{CC} = 2.0$ V - - - - -	0 to 1,000 ns
$V_{CC} = 4.5$ V - - - - -	0 to 500 ns
$V_{CC} = 6.0$ V - - - - -	0 to 400 ns

2. APPLICABLE DOCUMENTS

2.1 Government specification and standard. Unless otherwise specified, the following specification and standard, of the issue listed in that issue of the Department of Defense Index of Specifications and Standards specified in the solicitation, form a part of this drawing to the extent specified herein.

SPECIFICATION

MILITARY

MIL-M-38510 - Microcircuits, General Specification for.

STANDARD

MILITARY

MIL-STD-883 - Test Methods and Procedures for Microelectronics.

(Copies of the specification and standard required by manufacturers in connection with specific acquisition functions should be obtained from the contracting activity or as directed by the contracting activity.)

2.2 Order of precedence. In the event of a conflict between the text of this drawing and the references cited herein, the text of this drawing shall take precedence.

3. REQUIREMENTS

3.1 Item requirements. The individual item requirements shall be in accordance with 1.2.1 of MIL-STD-883, "Provisions for the use of MIL-STD-883 in conjunction with compliant non-JAN devices" and as specified herein.

3.2 Design, construction, and physical dimensions. The design, construction, and physical dimensions shall be as specified in MIL-M-38510 and herein.

3.2.1 Terminal connections. The terminal connections shall be as specified on figure 1.

3.2.2 Truth table. The truth table shall be as specified on figure 2.

3.2.3 Case outlines. The case outlines shall be in accordance with 1.2.2 herein.

3.3 Electrical performance characteristics. Unless otherwise specified, the electrical performance characteristics are as specified in table I and apply over the full case operating temperature range.

3.4 Marking. Marking shall be in accordance with MIL-STD-883 (see 3.1 herein). The part shall be marked with the part number listed in 1.2 herein. In addition, the manufacturer's part number may also be marked as listed in 6.4 herein.

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TABLE I. Electrical performance characteristics.

Test	Symbol	Conditions -55°C ≤ T _C ≤ +125°C, unless otherwise specified 1/		Group A subgroups	Limits		Unit
					Min	Max	
High level output voltage	V _{OH}	$V_{IN} = V_{IH} \text{ or } V_{IL}$ $ I_O \leq 20 \mu A$	V _{CC} = 2.0 V	1, 2, 3	1.9		V
			V _{CC} = 4.5 V		4.4		
			V _{CC} = 6.0 V		5.9		
		$V_{IN} = V_{IH} \text{ or } V_{IL}$ $ I_O \leq 4.0 \text{ mA}$	V _{CC} = 4.5 V		3.7		
			V _{CC} = 6.0 V		5.2		
Low level output voltage	V _{OL}	$V_{IN} = V_{IH} \text{ or } V_{IL}$ $ I_O \leq 20 \mu A$	V _{CC} = 2.0 V	1, 2, 3		0.1	V
			V _{CC} = 4.5 V			0.1	
			V _{CC} = 6.0 V			0.1	
		$V_{IN} = V_{IH} \text{ or } V_{IL}$ $ I_O \leq 4.0 \text{ mA}$	V _{CC} = 4.5 V			0.4	
			V _{CC} = 6.0 V			0.4	
High level input voltage 2/	V _{IH}		V _{CC} = 2.0 V	1, 2, 3	1.5		V
			V _{CC} = 4.5 V		3.15		
			V _{CC} = 6.0 V		4.2		
Low level input voltage 2/	V _{IL}		V _{CC} = 2.0 V	1, 2, 3		0.3	V
			V _{CC} = 4.5 V			0.9	
			V _{CC} = 6.0 V			1.2	
Input capacitance	C _{IN}	V _{IN} = 0 V T _C = +25°C See 4.3.1c		4		10	pF
Quiescent current	I _{CC}	V _{CC} = 6.0 V _{IN} = V _{CC} or GND		1, 2, 3		40	μA
Input leakage current	I _{IN}	V _{CC} = 6.0 V _{IN} = V _{CC} or GND		1, 2, 3		±1	μA
Functional tests		See 4.3.1d		7			

See footnotes at end of table.

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TABLE I. Electrical performance characteristics - Continued.

Test	Symbol	Conditions. -55°C < T _C < +125°C, unless otherwise specified 1/		Group A subgroups	Limits		Unit
					Min	Max	
Propagation delay time, high-to-low, low-to-high 3/	t _{PHL} , t _{PLH}	T _C = +25°C C _L = 50 pF ±10%	V _{CC} = 2.0 V	9		125	ns
			V _{CC} = 4.5 V			25	
			V _{CC} = 6.0 V			21	
		T _C = -55°C +125°C C _L = 50 pF ±10%	V _{CC} = 2.0 V	10, 11		190	ns
			V _{CC} = 4.5 V			38	
			V _{CC} = 6.0 V			32	
Transition time, high-to-low, low-to-high 4/	t _{THL} , t _{TLH}	T _C = +25°C C _L = 50 pF ±10%	V _{CC} = 2.0 V	9		75	ns
			V _{CC} = 4.5 V			15	
			V _{CC} = 6.0 V			13	
		T _C = -55°C +125°C C _L = 50 pF ±10%	V _{CC} = 2.0 V	10, 11		110	ns
			V _{CC} = 4.5 V			22	
			V _{CC} = 6.0 V			19	

1/ For a power supply of 5 V ±10% the worst case output voltages (V_{OH} and V_{OL}) occur for HC at 4.5 V. Thus the 4.5 V values should be used when designing with this supply. Worst case V_{IH} and V_{IL} occur at V_{CC} = 5.5 V and 4.5 V respectively. (The V_{IH} value at 5.5 V is 3.85 V.) The worst case leakage current (I_{IN}, I_{CC}, and I_{OZ}) occur for CMOS at the higher voltage and so the 6.0 V values should be used. Power dissipation capacitance (C_{PD}), typically 35 pF, determines the no load dynamic power consumption, P_D = C_{PD} V_{CC}² f + I_{CC} V_{CC}, and the no load dynamic current consumption, I_S = C_{PD} V_{CC} f + I_{CC}.

2/ Testing not required if applied as forcing function for V_{OH} or V_{OL}.

3/ Propagation delay times, when V_{CC} = 2.0 V and 6.0 V shall be guaranteed if not tested to the specified parameters.

4/ Transition time (t_{THL}, t_{TLH}), if not tested, shall be guaranteed to the specified limits.

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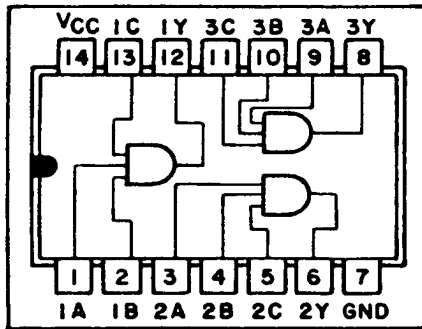
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Device type 01

Cases A, B, C, and D



Case 2

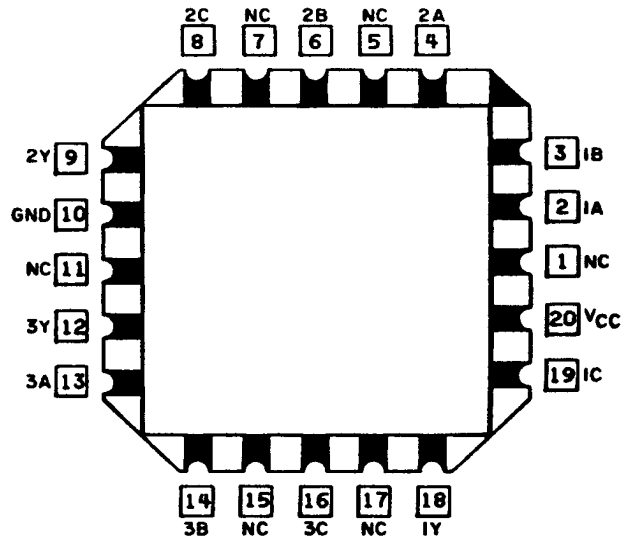


FIGURE 1. Terminal connections (top view).

Device type 01

Truth table each gate			
Input			Output
A	B	C	Y
L	L	L	L
H	L	L	L
L	H	L	L
H	H	L	L
L	L	H	L
H	L	H	L
L	H	H	L
H	H	H	H

Positive logic Y = ABC

FIGURE 2. Truth table.

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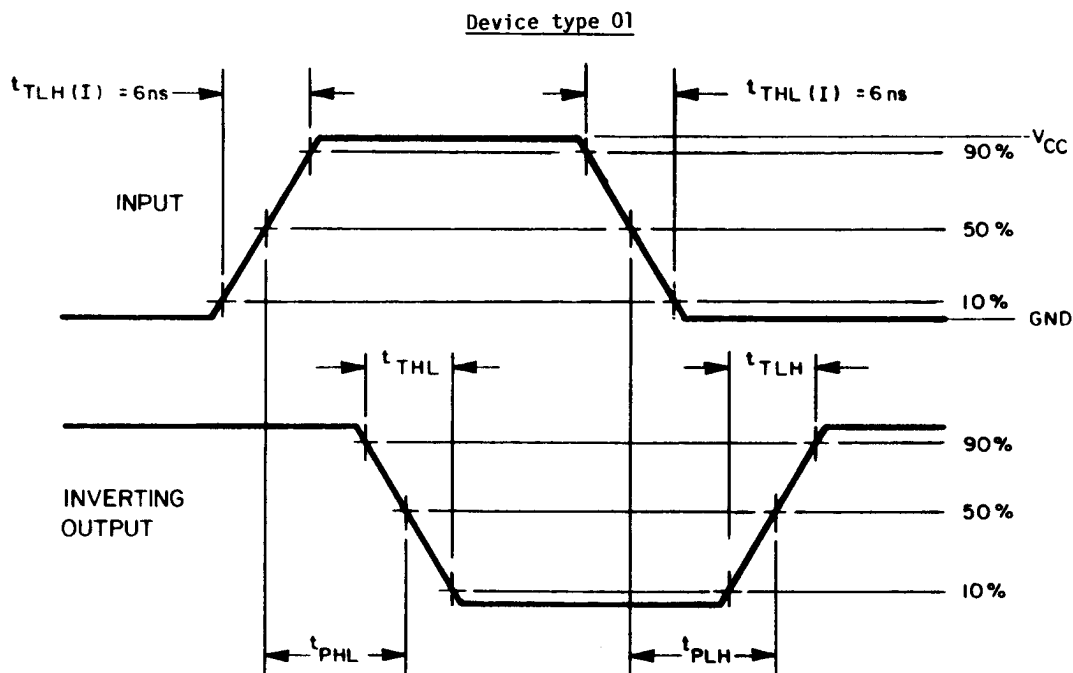


FIGURE 3. Switching waveforms.

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3.5 Certificate of compliance. A certificate of compliance shall be required from a manufacturer in order to be listed as an approved source of supply in 6.4. The certificate of compliance submitted to DESC-ECS prior to listing as an approved source of supply shall state that the manufacturer's product meets the requirements of MIL-STD-883 (see 3.1 herein) and the requirements herein.

3.6 Certificate of conformance. A certificate of conformance as required in MIL-STD-883 (see 3.1 herein) shall be provided with each lot of microcircuits delivered to this drawing.

3.7 Notification of change. Notification of change to DESC-ECS shall be required in accordance with MIL-STD-883 (see 3.1 herein).

3.8 Verification and review. DESC, DESC's agent, and the acquiring activity retain the option to review the manufacturer's facility and applicable required documentation. Offshore documentation shall be made available onshore at the option of the reviewer.

4. QUALITY ASSURANCE PROVISIONS

4.1 Sampling and inspection. Sampling and inspection procedures shall be in accordance with section 4 of MIL-M-38510 to the extent specified in MIL-STD-883 (see 3.1 herein).

4.2 Screening. Screening shall be in accordance with method 5004 of MIL-STD-883, and shall be conducted on all devices prior to quality conformance inspection. The following additional criteria shall apply:

a. Burn-in test, method 1015 of MIL-STD-883.

(1) Test condition A, B, C, or D using the circuit submitted with the certificate of compliance (see 3.5 herein).

(2) $T_A = +125^{\circ}\text{C}$, minimum.

b. Interim and final electrical test parameters shall be as specified in table II herein, except interim electrical parameter tests prior to burn-in are optional at the discretion of the manufacturer.

4.3 Quality conformance inspection. Quality conformance inspection shall be in accordance with method 5005 of MIL-STD-883 including groups A, B, C, and D inspections. The following additional criteria shall apply.

4.3.1 Group A inspection.

a. Tests shall be as specified in table II herein.

b. Subgroups 5, 6, and 8 in table I, method 5005 of MIL-STD-883 shall be omitted.

c. Subgroup 4 (C_{IN} measurement) shall be measured only for the initial test and after process or design changes which may affect input capacitance.

d. Subgroup 7 tests sufficiently to verify the truth table.

4.3.2 Groups C and D inspections.

a. End-point electrical parameters shall be as specified in table II herein.

b. Steady-state life test conditions; method 1005 of MIL-STD-883:

(1) Test condition A, B, C, or D using the circuit submitted with the certificate of compliance (see 3.5 herein).

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TABLE II. Electrical test requirements.

MIL-STD-883 test requirements	Subgroups (per method 5005, table I)
Interim electrical parameters (method 5004)	---
Final electrical test parameters (method 5004)	1*, 2, 9
Group A test requirements (method 5005)	1, 2, 3, 4, 7, 9, 10, 11**
Groups C and D end-point electrical parameters (method 5005)	1, 2, 3

* PDA applies to subgroup 1.

** Subgroups 10 and 11, if not tested, shall be guaranteed to the specified limits in table I.

(2) $T_A = +125^\circ\text{C}$, minimum.

(3) Test duration: 1,000 hours, except as permitted by appendix B of MIL-M-38510 and method 1005 of MIL-STD-883.

5. PACKAGING

5.1 Packaging requirements. The requirements for packaging shall be in accordance with MIL-M-38510.

6. NOTES

6.1 Intended use. Microcircuits conforming to this drawing are intended for use when military specifications do not exist and qualified military devices that will perform the required function are not available for OEM application. When a military specification exists and the product covered by this drawing has been qualified for listing on QPL-38510, the device specified herein will be inactivated and will not be used for new design. The QPL-38510 product shall be the preferred item for all applications.

6.2 Replaceability. Replaceability is determined as follows:

- Microcircuits covered by this drawing will replace the same generic device covered by a contractor-prepared specification or drawing.
- When a QPL source is established, the part numbered device specified in this drawing will be replaced by the microcircuit identified as part number M38510/65204B--.

6.3 Comments. Comments on this drawing should be directed to DESC-ECS, Dayton, Ohio 45444, or telephone 513-296-5375.

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6.4 Approved sources of supply. Approved sources of supply are listed herein. Additional sources will be added as they become available. The vendors listed herein have agreed to this drawing and a certificate of compliance (see 3.5 herein) has been submitted to DESC-ECS.

Military drawing part number	Vendor CAGE number	Vendor similar part number 1/	Replacement military specification part number
8404801AX <u>2/</u>		MM54HC11W/883B	M38510/65204BAX
8404801BX	01295	SNJ54HC11WA	M38510/65204BBX
8404801CX <u>3/</u>	01295	SNJ54HC11J	M38510/65204BCX
	18714	CD54HC11F/3A	
	27014	MM54HC11J/883B	
	04713	54HC11/BCAJC	
8404801DX	01295	SNJ54HC11W	M38510/65204BDX
	27014	MM54HC11W/883B	
84048012X <u>4/</u>	01295	SNJ54HC11FK	M38510/65204B2X
	04713	54HC11M/B2CJC	
	27014	MM54HC11E/883	

1/ Caution. Do not use this number for item acquisition. Items acquired to this number may not satisfy the performance requirements of this drawing.

2/ Not available from an approved source of supply.

3/ Inactive for new design. Use M38510/65204BCX.

4/ Inactive for new design. Use M38510/65204B2X.

Vendor CAGE
number

Vendor name
and address

01295

Texas Instruments, Incorporated
P.O. Box 6448
Midland, TX 79701

04713

Motorola, Incorporated
7402 S. Price Road
Tempe, AZ 85283

18714

RCA Solid State Division
Route 202
Somerville, NJ 08876

27014

National Semiconductor
2900 Semiconductor Drive
Santa Clara, CA 95051

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